

15A, 700V N-CHANNEL POWER MOSFET

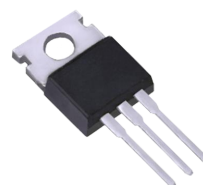
■ DESCRIPTION

The UTC **15N70** is an N-Channel enhancement MOSFET, it uses UTC's advanced technology to provide customers with a minimum on-state resistance, high switching speed and low gate charge. It can also withstand high energy pulse in the avalanche and commutation modes.

The UTC **15N70** is suitable for high efficiency switching DC/DC converter, motor control and switch mode power supply.

■ FEATURES

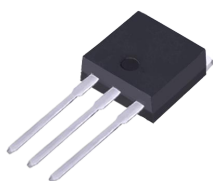
- * $R_{DS(ON)}=0.43\Omega$ @ $V_{GS}=10V, I_D=7.5A$
- * Low gate charge (Typ=70nC)
- * Low C_{RSS} (Typ=27pF)
- * High switching speed



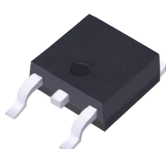
T0-220



T0-220F



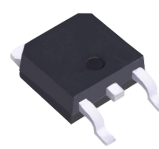
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T0-263



T0-251



T0-252

■ ABSOLUTE MAXIMUM RATINGS ($T_C=25^\circ\text{C}$, unless otherwise noted)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	700	V	
Gate-Source Voltage		V_{GSS}	± 30	V	
Drain Current	Continuous	I_D	$T_C=25^\circ\text{C}$	15	A
			$T_C=100^\circ\text{C}$	9.5	A
	Pulsed (Note 2)	I_{DM}	60	A	
Avalanche Current (Note 2)		I_{AR}	15	A	
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	950	mJ	
	Repetitive (Note 2)	E_{AR}	30	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation ($T_C=25^\circ\text{C}$)		P_D	300	W	
Derate above 25°C			2.38	W/ $^\circ\text{C}$	
Junction Temperature		T_J	$-55\sim+150$	$^\circ\text{C}$	
Storage Temperature Range		T_{STG}	$-55\sim+150$	$^\circ\text{C}$	
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 5 Seconds		T_L	300	$^\circ\text{C}$	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive rating; pulse width limited by max. junction temperature.

3. $L=7.8\text{mH}$, $I_{AS}=15\text{A}$, $V_{DD}=50\text{V}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$,

4. $I_{SD}\leq 15\text{A}$, $di/dt\leq 200\text{A}/\mu\text{s}$, $V_{DD}\leq BV_{DSS}$, $T_J\leq 25^\circ\text{C}$.

■ THERMAL CHARACTERISTICS

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	40	$^\circ\text{C}/\text{W}$
Junction to Case	θ_{JC}	0.42	$^\circ\text{C}/\text{W}$
Case to Sink	θ_{CS}	0.24	$^\circ\text{C}/\text{W}$

■ ELECTRICAL CHARACTERISTICS ($T_C=25^\circ\text{C}$, unless otherwise noted)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	$I_D=250\mu\text{A}$, $V_{GS}=0\text{V}$	700			V
Breakdown Voltage Temperature Coefficient		$\Delta BV_{DSS}/\Delta T_J$	Reference to 25°C , $I_D=250\mu\text{A}$		0.68		$\text{V}/^\circ\text{C}$
Drain-Source Leakage Current		I_{DSS}	$V_{DS}=700\text{V}$, $V_{GS}=0\text{V}$			10	μA
			$V_{DS}=560\text{V}$, $T_C=125^\circ\text{C}$			100	μA
Gate-Source Leakage Current	Forward	I_{GSS}	$V_{GS}=+30\text{V}$, $V_{DS}=0\text{V}$			+100	nA
	Reverse		$V_{GS}=-30\text{V}$, $V_{DS}=0\text{V}$			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$	3.0		5.0	V
Static Drain-Source On-State Resistance		$R_{DS(ON)}$	$V_{GS}=10\text{V}$, $I_D=7.5\text{A}$		0.43	0.56	Ω
Forward Transconductance		g_{FS}	$V_{DS}=50\text{V}$, $I_D=7.5\text{A}$ (Note 1)		15		S
DYNAMIC PARAMETERS							
Input Capacitance		C_{ISS}	$V_{GS}=0\text{V}$, $V_{DS}=25\text{V}$, $f=1.0\text{MHz}$		2790	3600	pF
Output Capacitance		C_{OSS}			300	390	pF
Reverse Transfer Capacitance		C_{RSS}			27	35	pF
SWITCHING PARAMETERS							
Total Gate Charge		Q_G	$V_{GS}=10\text{V}$, $V_{DS}=560\text{V}$, $I_D=15\text{A}$ (Note 1, 2)		70	90	nC
Gate to Source Charge		Q_{GS}			17		nC
Gate to Drain Charge		Q_{GD}			33		nC
Turn-ON Delay Time		$t_{D(ON)}$	$V_{DD}=350\text{V}$, $I_D=15\text{A}$, $R_G=25\Omega$ (Note 1, 2)		70	150	ns
Rise Time		t_R			180	370	ns
Turn-OFF Delay Time		$t_{D(OFF)}$			160	330	ns
Fall-Time		t_F			120	250	ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS							
Maximum Body-Diode Continuous Current		I_S				15	A
Maximum Body-Diode Pulsed Current		I_{SM}				60	A
Drain-Source Diode Forward Voltage		V_{SD}	$I_S=15\text{A}$, $V_{GS}=0\text{V}$			1.4	V
Body Diode Reverse Recovery Time		t_{RR}	$I_S=15\text{A}$, $V_{GS}=0\text{V}$, $di_F/dt=100\text{A}/\mu\text{s}$ (Note1)		460		ns
Body Diode Reverse Recovery Charge		Q_{RR}			5.7		μC

- Notes: 1. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
2. Essentially independent of operating temperature